

MOS FIELD EFFECT TRANSISTOR μ PA2756GR

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA2756GR is Dual N-channel MOS Field Effect Transistor designed for switching applications.

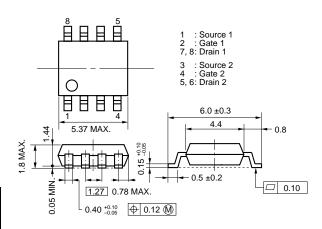
FEATURES

- · Low on-state resistance
- $R_{DS(on)1}$ = 105 m Ω MAX. (Vgs = 10 V, ID = 2.0 A)
- $R_{DS(on)2}$ = 150 m Ω MAX. (Vgs = 4.0 V, ID = 2.0 A)
- Low Ciss: Ciss = 260 pF TYP.
- Built-in G-S protection diode against ESD
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA2756GR	Power SOP8

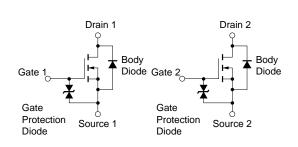
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C)

Drain to Source Voltage (Vgs = 0 V)	Voss	60	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
Drain Current (DC) Note1	ID(DC)	±4.0	Α
Drain Current (pulse) Note2	I _{D(pulse)}	±16	Α
Total Power Dissipation (1 unit) Note1	P _{T1}	1.6	W
Total Power Dissipation (2 units) Note1	P _{T2}	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C
Single Avalanche Current Note3	las	4.0	Α
Single Avalanche Energy Note3	Eas	1.6	m
Repetitive Avalanche Energy Note4	Ear	1.6	m

EQUIVALENT CIRCUIT



- Notes 1. Mounted on ceramic substrate of 2000 mm² x 2.2 mm
 - **2.** PW \leq 10 μ s, Duty Cycle \leq 1%
 - 3. Starting T_{ch} = 25°C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V
 - **4.** IAR ≤ 4.0 A, Tch $\leq 150^{\circ}$ C

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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ELECTRICAL CHARACTERISTICS (TA = 25°C)

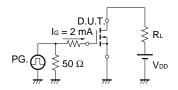
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 60 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	V _{GS} = ±18 V, V _{DS} = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	٧
Forward Transfer Admittance Note	y fs	V _{DS} = 10 V, I _D = 2.0 A	2.0			S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = 10 V, I _D = 2.0 A		85	105	mΩ
	RDS(on)2	V _{GS} = 4.0 V, I _D = 2.0 A		106	150	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		260		pF
Output Capacitance	Coss	V _{GS} = 0 V		65		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		20		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 2.0 A		14		ns
Rise Time	t r	V _{GS} = 10 V		5		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		80		ns
Fall Time	tf			30		ns
Total Gate Charge	Q _G	V _{DD} = 48 V		6		nC
Gate to Source Charge	Qgs	V _{GS} = 10 V		1		nC
Gate to Drain Charge	Q _{GD}	I _D = 4.0 A		1.5		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 4.0 A, V _{GS} = 0 V		0.9		V
Reverse Recovery Time	trr	I _F = 4.0 A, V _{GS} = 0 V		24		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		22		nC

Note Pulsed

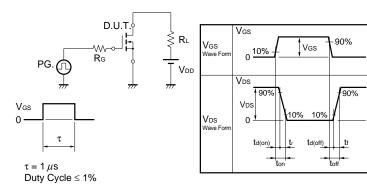
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{GS} = 20 \rightarrow 0 \text{ V}$ V_{DS} V_{DS} V_{DS} V_{DS} V_{DS}

TEST CIRCUIT 3 GATE CHARGE

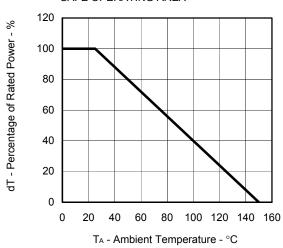


TEST CIRCUIT 2 SWITCHING TIME

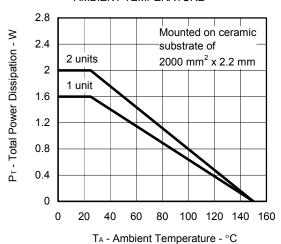


TYPICAL CHARACTERISTICS (TA = 25°C)

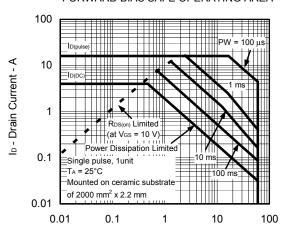
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE

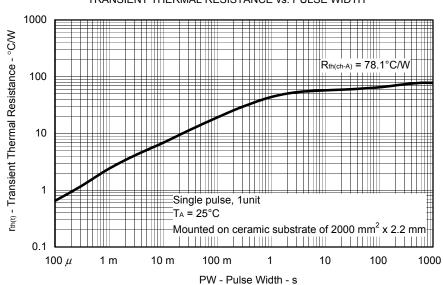


FORWARD BIAS SAFE OPERATING AREA



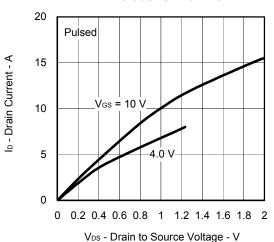
$V_{\text{\scriptsize DS}}$ - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

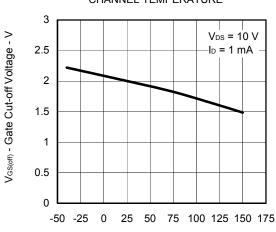


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DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

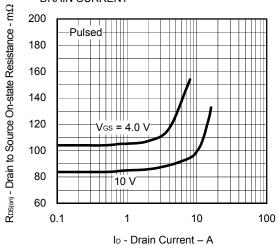


GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

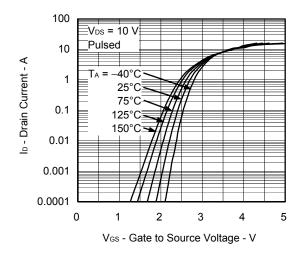


DRAIN TO SOURCE ON-STATE RESISTANCE vs. **DRAIN CURRENT**

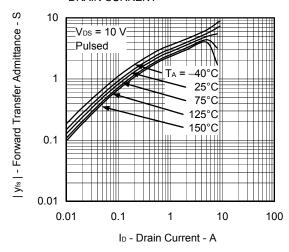
Tch - Channel Temperature - °C



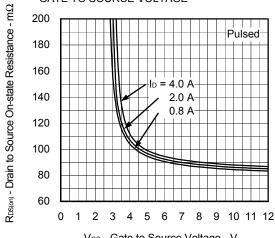
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

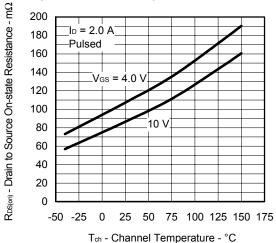


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

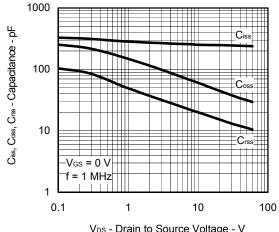


V_{GS} - Gate to Source Voltage - V

DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

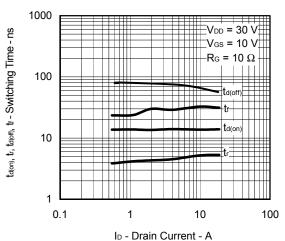


CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

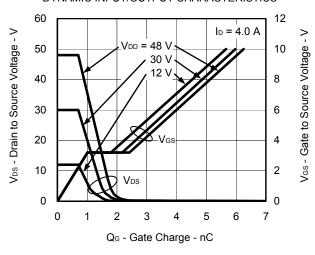


VDS - Drain to Source Voltage - V

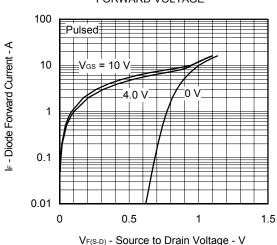
SWITCHING CHARACTERISTICS



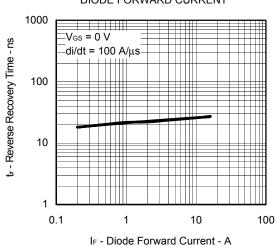
DYNAMIC INPUT/OUTPUT CHARACTERISTICS

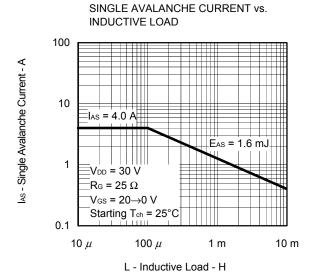


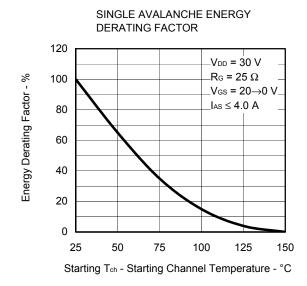
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT







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